



Material No.: 9731-03 Batch No.: 0000003004 Manufactured Date: 2012/04/25

Certificate of Analysis

Test	S pecification	Result
Appearance	Passes Test	PT
Assay (as NH₃)	28.0 -30.0 %	28.7
Color (APHA)	<= 7	< 5
Insoluble Matter	<= 1 ppm	<1
Residue after Ignition	<= 3 ppm	< 3
Carbon Dioxide (CO2)	<= 10 ppm	<10
Pyridine	Passes Test	PT
Substances Reducing Permanganate	Passes Test	PT
Chloride (CI)	<= 0.3 ppm	< 0.2
Phosphate (PO ₄)	<= 0.2 ppm	< 0.2
Total Sulfur (as SO4)	<= 0.8 ppm	< 0.2
Trace Impurities -Aluminum (Al)	<= 10.0 ppb	< 5.0
Trace Impurities -Arsenic (As)	<= 50.0 ppb	< 2.0
Arsenic and Antimony (as As)	<= 30 ppb	< 5
Trace Impurities –Barium (Ba)	<= 10.0 ppb	< 1.0
Trace Impurities –Beryllium (Be)	<= 10.0 ppb	< 1.0
Trace Impurities -Bismuth (Bi)	<= 20.0 ppb	< 10.0
Trace Impurities -Boron (B)	<= 10.0 ppb	< 5.0
Trace Impurities –Cadmium (Cd)	<= 5.0 ppb	< 1.0
Trace Impurities -Calcium (Ca)	<= 100.0 ppb	3.0
Trace Impurities -Chromium (Cr)	<= 5.0 ppb	< 1.0
Trace Impurities –Cobalt (Co)	<= 1.0 ppb	< 1.0
Trace Impurities -Copper (Cu)	<= 10.0 ppb	< 1.0
Trace Impurities –Gallium (Ga)	<= 10.0 ppb	< 1.0

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Trace Impurities –Germanium (Ge)	<= 50.0 ppb	< 10.0
Trace Impurities –Gold (Au)	<= 10.0 ppb	< 5.0
Heavy Metals (as Pb)	<= 200 ppb	< 100
Trace Impurities –Iron (Fe)	<= 10.0 ppb	1.0
Trace Impurities -Lead (Pb)	<= 10.0 ppb	< 10.0
Trace Impurities -Lithium (Li)	<= 10.0 ppb	< 1.0
Trace Impurities – Magnesium (Mg)	<= 50.0 ppb	< 1.0
Trace Impurities – Manganese (Mn)	<= 5.0 ppb	< 1.0
Trace Impurities – Molybdenum (Mo)	<= 10.0 ppb	< 5.0
Trace Impurities - Nickel (Ni)	<= 5.0 ppb	< 5.0
Trace Impurities - Niobium (Nb)	<= 10.0 ppb	< 1.0
Trace Impurities –Potassium (K)	<= 100.0 ppb	< 10.0
Trace Impurities – Silicon (Si)	<= 150.0 ppb	< 10.0
Trace Impurities –Silver (Ag)	<= 5.0 ppb	< 1.0
Trace Impurities –S odium (Na)	<= 100.0 ppb	< 5.0
Trace Impurities –S trontium (S r)	<= 10.0 ppb	<1.0
Trace Impurities –Tantalum (Ta)	<= 10.0 ppb	< 5.0
Trace Impurities -Thallium (TI)	<= 20.0 ppb	< 5.0
Trace Impurities -Tin (S n)	<= 20.0 ppb	< 10.0
Trace Impurities – Titanium (Ti)	<= 10.0 ppb	< 1.0
Trace Impurities -Vanadium (V)	<= 10.0 ppb	< 1.0
Trace Impurities –Zinc (Zn)	<= 5.0 ppb	1.0
Trace Impurities – Zirconium (Zr)	<= 10.0 ppb	< 1.0
Particle Count –0.5 µm and greater	<= 80 par/ml	21
Particle Count – 1.0 µm and greater	<= 10 par/ml	7

For Microelectronic Use

Storage Conditions:

Country of Origin: US

Packaging Site: Paris Mfg Ctr & DC



Phillipsburg, NJ 9001.2008, 14001.2004 Paris, KY 9001.2008 Mexico city, Mexico 9001.2008 Deventer, The Netherlands 9001.2008, 14001.2004 Selangor, Malaysia 9001.2008 Panoli, India 9001.2008 Gliwice, Poland 9001.2008,17025.2005

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